

CRADA

Personal Identity Verification
Demonstration

CRADA

- “Cooperative Research and Development Agreement”
- Provides NIST the opportunity to conduct interoperability demonstrations of FIPS 201 using commercially available products
- PIV demonstrations will be open only to federal agencies

Plan for PIV Demonstrations

- The demonstration period is 4 weeks
 - **Week One:** Vendor installations
 - **Weeks Two & Three:** In-depth vendor demonstrations to NIST staff
 - **Week Four:** Agency demonstrations and removal of equipment
- Tentative dates are May 15 – June 14
- Final schedule available at:
 - <http://csrc.nist.gov/piv-program/CRADA/demos.html>

Current Status

- For the first call for participation:
 - 45 vendors contacted NIST
 - 30 vendors signed agreements
 - 27 agreements executed as of March 30
- For the second call for participation:
 - 13 vendors contacted NIST as of March 30
 - 1 vendor signed as of March 30
 - 0 agreements executed as of March 30

Participating Vendors

- **PIV Cards & Middleware**
 - G & D
 - Gemplus
 - Oberthur
 - Sagem Morpho
 - StepNexus
- **Registration & Enrollment**
 - Centech Group
 - InfoMosaic
- **Card Issuance & Management**
 - ACI Worldwide
 - ActivIdentity
 - Datacard
 - Entrust
 - Fargo Electronics
 - Gemplus
 - Probaris
 - RSA
 - Secure Network Systems
 - Ultra Electronics
 - Viisage

Participating Vendors

- **Logical Access Components**

- Cogent
- Entrust
- Novell
- Quintron
- TecSec

- **Physical Access Components**

- AMAG Technology
- BQT
- BridgePoint
- Cogent
- Hirsch
- MDI
- Middleware Associates
- Quintron
- Software House (Tyco)
- Veridt

Participating Vendors

- **Integrated Solutions**

- ADT
- Anteon
- Centech Group
- Honeywell
- Lenel
- Lockheed Martin
- SETECS
- XTec

- **Biometric Solutions**

- Aware
- EC4 Technologies
- Identix

- **Card Readers**

- Integrated Engineering
- SCM Microsystems

For Further Information

- General Information:
 - <http://csrc.nist.gov/piv-program/CRADA>
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